

Notice of References Cited	Application/Control No. 10/754,815	Applicant(s)/Patent Under Reexamination NAKAYA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,075,909	07-2006	Iinuma, Toshinori	370/329
*	C	US-7,110,480	09-2006	Iinuma, Toshinori	375/347
*	D	US-6,665,308	12-2003	Rakib et al.	370/441
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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